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December 2014

FGH12040WD 1200 V, 40 A Field Stop Trench IGBT

Features

- Maximum Junction Temperature : T_J = 175°C
- · Positive Temperature Co-efficient for Easy Parallel Operating
- Low Saturation Voltage: $V_{CE(sat)} = 2.3 \text{ V (Typ.)} @ I_C = 40 \text{ A}$
- 100% of The Parts Tested for $I_{LM}^{(1)}$
- Short Circuit Ruggedness > 5 us @ 150°C
- · High Input Impedance
- · RoHS Compliant

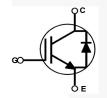
General Description

Using novel field stop IGBT technology, Fairchild's new series of field stop 2nd generation IGBTs offer the optimum performance for welder applications where low conduction and switching losses are essential.

Applications

· Only for Welder





Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description		FGH12040WD_F	FGH12040WD_F155	
V _{CES}	Collector to Emitter Voltage		1200		V
V _{GES}	Gate to Emitter Voltage		±25		V
	Transient Gate to Emitter Voltage		±30		V
I _C	Collector Current	$@ T_C = 25^{\circ}C$	80		Α
i.C	Collector Current	$@T_{C} = 100^{\circ}C$	40		Α
I _{LM (1)}	Clamped Inductive Load Current	@ T _C = 25°C	100		Α
I _{CM (2)}	Pulsed Collector Current		100		Α
I _F	Diode Continuous Forward Current	@ T _C = 25°C	80		Α
·F	Diode Continuous Forward Current	@ T _C = 100°C	40		Α
I _{FM (2)}	Diode Maximum Forward Current		100		Α
SCWT (3)	Short Circuit Withstand Time,	@ T _C = 150°C	5		us
P _D	Maximum Power Dissipation	@ T _C = 25°C	428		W
י ט	Maximum Power Dissipation	@ T _C = 100°C	214		W
T _J	Operating Junction Temperature		-55 to +175		°C
T _{stg}	Storage Temperature Range		-55 to +175		°C
T _L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds	3	300		°C

- 1. V_{CC} = 600 V, V_{GE} = 15 V, I_C = 100 A, R_G = 23 Ω , Inductive Load 2. Repetitive rating : Pulse width limited by max, junction temperature 3. V_{CC} = 600 V, V_{GE} = 12 V

Thermal Characteristics

Symbol	Parameter	FGH12040WD_F155	Unit
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case	0.35	°C/W
$R_{\theta JC}(Diode)$	Thermal Resistance, Junction to Case	1.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	40	°C/W

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FGH12040WD_F155	FGH12040WD	TO-247 G03	Tube	-	-	30

Electrical Characteristics of the IGBT $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV _{CES}	Collector to Emitter Breakdown Voltage	V _{GE} = 0 V, I _C = 250 uA	1200	-	-	V
ΔBV _{CES} / ΔΤ _J	Temperature Coefficient of Breakdown Voltage	V _{GE} = 0 V, I _C = 250 uA	-	1.2	-	V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}$, $V_{GE} = 0$ V	-	-	250	uA
I _{GES}	G-E Leakage Current	V _{GE} = V _{GES} , V _{CE} = 0 V	-	-	±400	nA
On Charac	eteristics					
V _{GE(th)}	G-E Threshold Voltage	I_C = 40 mA, V_{CE} = V_{GE}	4.8	6.4	8.0	V
		I _C = 40 A, V _{GE} = 15 V T _C = 25°C	-	2.3	2.9	٧
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 40 A, V _{GE} = 15 V, T _C = 175°C	-	2.7	-	٧
Dynamic C	Characteristics		•			
C _{ies}	Input Capacitance		-	2800	-	pF
C _{oes}	Output Capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$ f = 1MHz	-	105	-	pF
C _{res}	Reverse Transfer Capacitance	11 - 11VII 12	-	60	-	pF
Switching	Characteristics					9/
t _{d(on)}	Turn-On Delay Time		-	45		
t _r	Diag Time				-	ns
	Rise Time		<i>A</i> -	70	-	ns ns
$t_{d(off)}$	Turn-Off Delay Time	V _{CC} = 600 V, I _C = 40 A,	-	70 560		
t _{d(off)}		$V_{CC} = 600 \text{ V}, I_{C} = 40 \text{ A},$ $R_{G} = 23 \Omega, V_{GE} = 15 \text{ V},$		-	-	ns
t _f	Turn-Off Delay Time		-	560	-	ns ns
	Turn-Off Delay Time Fall Time	$R_G = 23 \Omega, V_{GE} = 15 V,$	-	560 15	-	ns ns ns
t _f E _{on}	Turn-Off Delay Time Fall Time Turn-On Switching Loss	$R_G = 23 \Omega, V_{GE} = 15 V,$	-	560 15 4.1	-	ns ns ns mJ
t _f E _{on} E _{off} E _{ts}	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss	$R_G = 23 \Omega, V_{GE} = 15 V,$	-	560 15 4.1 1.0	-	ns ns ns mJ
t _f E _{on} E _{off}	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss	$R_G = 23 \Omega, V_{GE} = 15 V,$		560 15 4.1 1.0 5.1	-	ns ns ns mJ mJ
t _f Eon Eoff Ets t _{d(on)}	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time	$R_G = 23 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25^{\circ}C$		560 15 4.1 1.0 5.1 43	-	ns ns ns mJ mJ mJ
t _f Eon Eoff Ets t _d (on) t _r	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time	$R_G = 23 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25^{\circ}C$ $V_{CC} = 600 V$, $I_C = 40 A$, $R_G = 23 \Omega$, $V_{GE} = 15 V$,	-	560 15 4.1 1.0 5.1 43 73	-	ns ns ns mJ mJ ms ns
t _f Eon Eoff Ets t _d (on) t _r t _d (off)	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time	$R_G = 23 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25^{\circ}C$		560 15 4.1 1.0 5.1 43 73 572		ns ns ns mJ mJ ms ns ns
t_f E_{on} E_{off} E_{ts} $t_{d(on)}$	Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$R_G = 23 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25^{\circ}C$ $V_{CC} = 600 V$, $I_C = 40 A$, $R_G = 23 \Omega$, $V_{GE} = 15 V$,		560 15 4.1 1.0 5.1 43 73 572 58		ns ns ns ns mJ mJ ms ns ns

Electrical Characteristics of the IGBT (continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Qg	Total Gate Charge	V _{CE} = 600 V, I _C = 40 A, V _{GE} = 15 V	-	226	-	nC
Q _{ge}	Gate to Emitter Charge		-	18	-	nC
Q _{gc}	Gate to Collector Charge		-	155	-	nC

Electrical Characteristics of the DIODE T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{FM}	Diode Forward Voltage	I _F = 40 A, T _C = 25°C	-	3.6	4.7	V
		I _F = 40 A, T _C = 175°C	-	2.9	-	V
t _{rr}	Diode Reverse Recovery Time		-	71	-	ns
I _{rr}	Diode Peak Reverse Recovery Current	$V_R = 600 \text{ V}, I_F = 40 \text{ A},$ $di_F/dt = 200 \text{ A/us}, T_C = 25^{\circ}\text{C}$	-	6.8	-	Α
Q _{rr}	Diode Reverse Recovery Charge		-	242	-	nC
E _{rec}	Reverse Recovery Energy		-	690	-	uJ
t _{rr}	Diode Reverse Recovery Time	$V_R = 600 \text{ V}, I_F = 40\text{A},$ $di_F/dt = 200 \text{ A/us}, T_C = 175^{\circ}\text{C}$	-	500	-	ns
I _{rr}	Diode Peak Reverse Recovery Current		-	17	-	Α
Q _{rr}	Diode Reverse Recovery Charge		-	4250	-	nC

Figure 1. Typical Output Characteristics

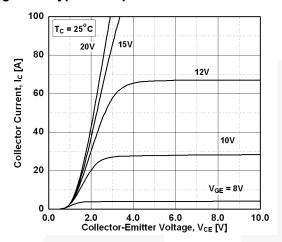


Figure 3. Typical Saturation Voltage Characteristics

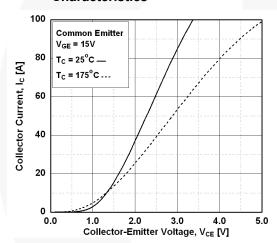


Figure 5. Saturation Voltage vs. V_{GE}

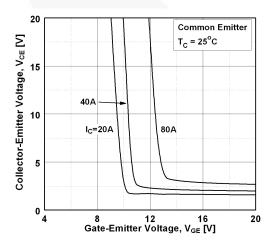


Figure 2. Typical Output Characteristics

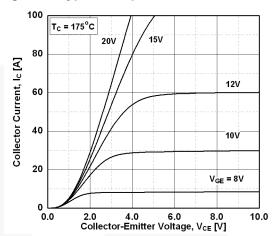


Figure 4. Saturation Voltage vs. Case
Temperature at Variant Current Level

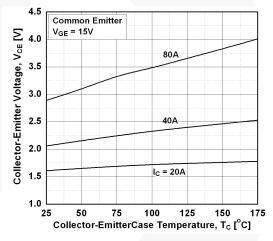


Figure 6. Saturation Voltage vs. V_{GE}

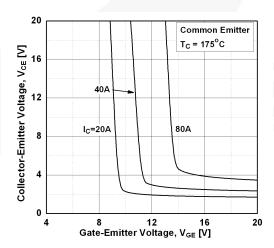


Figure 7. Capacitance Characteristics

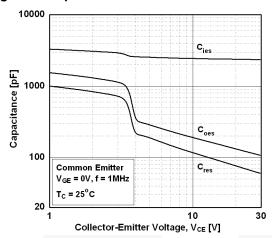


Figure 8. Gate Charge Characteristics

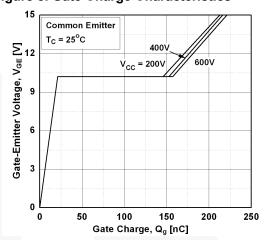


Figure 9. Turn-on Characteristics vs.
Gate Resistance

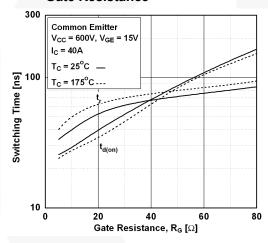


Figure 10. Turn-off Characteristics vs.
Gate Resistance

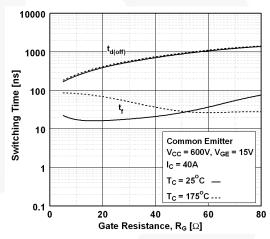


Figure 11. Swithcing Loss vs.

Gate Resistance

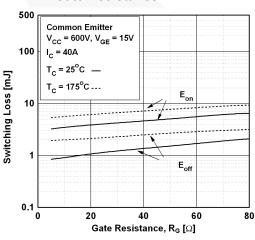


Figure 12. Turn-on Characteristics vs. Collector Current

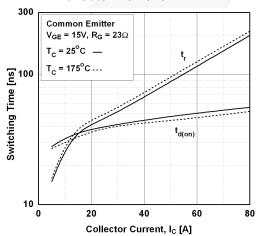


Figure 13. Turn-off Characteristics vs. Collector Current

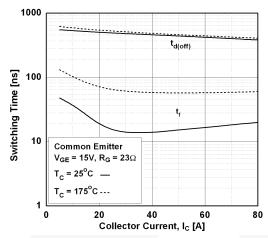


Figure 15. Load Current vs. Frequency

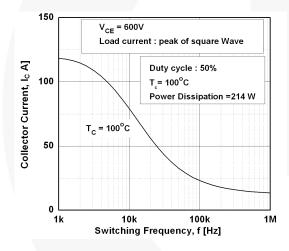


Figure 17. Forward Characteristics

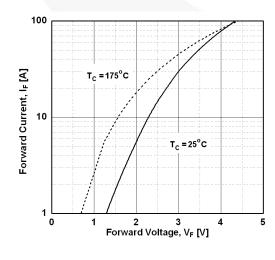


Figure 14. Swithcing Loss vs. Collector Current

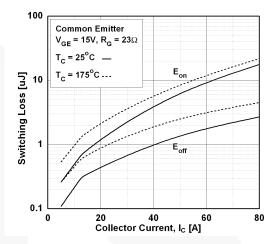


Figure 16. SOA Characteristics

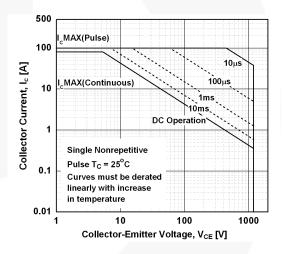


Figure 18. Reverse Recovery Current

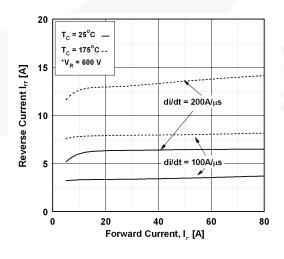


Figure 19. Reverse Recovery Time

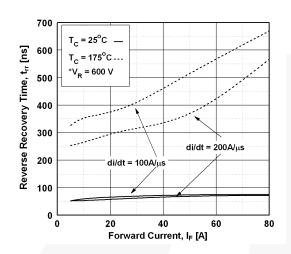


Figure 20. Stored Charge

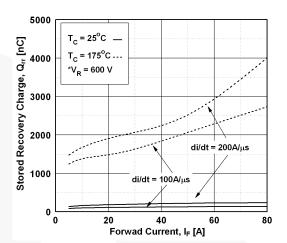


Figure 21. Transient Thermal Impedance of IGBT

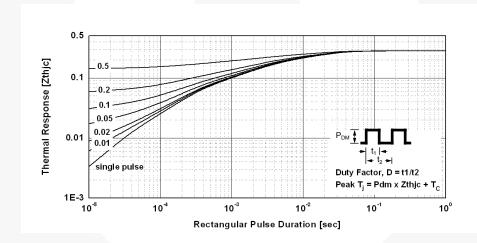
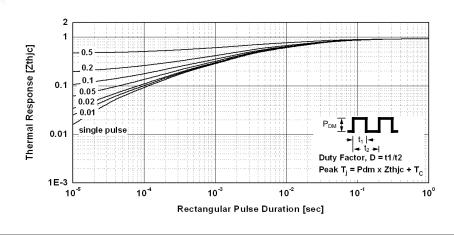
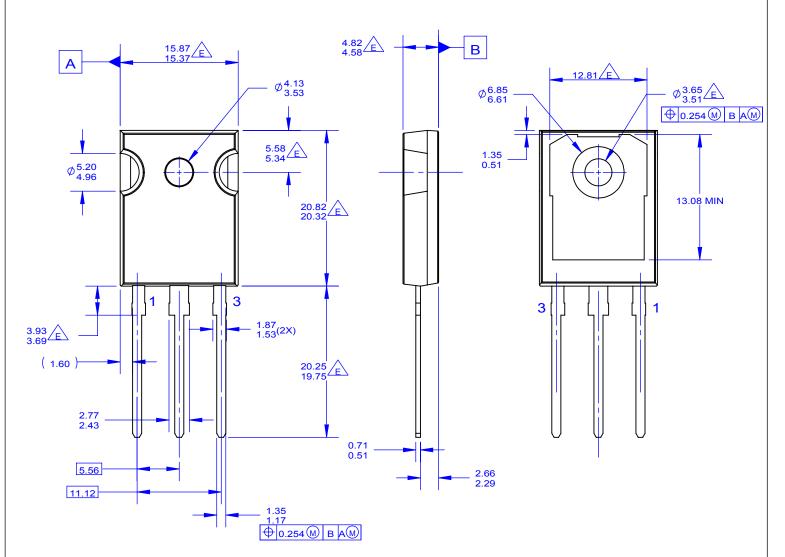


Figure 22. Transient Thermal Impedance of Diode





NOTES: UNLESS OTHERWISE SPECIFIED.

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- D. DRAWING CONFORMS TO ASME Y14.5 1994





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